

# FDN304P

# P-Channel 1.8V Specified PowerTrench® MOSFET

## **General Description**

This P-Channel 1.8V specified MOSFET uses Fairchild's advanced low voltage PowerTrench process. It has been optimized for battery power management applications.

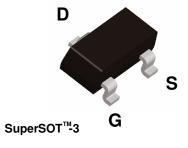
### **Applications**

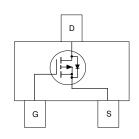
- · Battery management
- Load switch
- Battery protection

### **Features**

• -2.4 A, -20 V. 
$$\begin{split} R_{DS(ON)} &= 52 \text{ m}\Omega \text{ @ V}_{GS} = -4.5 \text{ V} \\ R_{DS(ON)} &= 70 \text{ m}\Omega \text{ @ V}_{GS} = -2.5 \text{ V} \\ R_{DS(ON)} &= 100 \text{ m}\Omega \text{ @ V}_{GS} = -1.8 \text{ V} \end{split}$$

- · Fast switching speed
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS(ON)}}$
- SuperSOT<sup>™</sup> -3 provides low R<sub>DS(ON)</sub> and 30% higher power handling capability than SOT23 in the same footprint





Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

| Symbol                            | Parameter  |           | Ratings     | Units |
|-----------------------------------|--|-----------|-------------|-------|
| V <sub>DSS</sub>                  | Drain-Source Voltage                             |           | -20         | V     |
| V <sub>GSS</sub>                  | Gate-Source Voltage                              |           | ±8          | V     |
| I <sub>D</sub>                    | Drain Current - Continuous                       | (Note 1a) | -2.4        | А     |
|                                   | - Pulsed   |           | -10         |       |
| P <sub>D</sub>                    | Maximum Power Dissipation                        | (Note 1a) | 0.5         | W     |
|                                   |  | (Note 1b) | 0.46        |       |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Range |           | -55 to +150 | °C    |

# **Thermal Characteristics**

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 250 | °C/W |
|-----------------|---|-----------|-----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case    | (Note 1)  | 75  | °C/W |

**Package Marking and Ordering Information** 

| Device Marking | Device         | Reel Size | Tape width | Quantity   |  |
|----------------|----------------|-----------|------------|------------|--|
| 304            | 304 FDN304P 7" |           | 8mm        | 3000 units |  |

| Symbol                                 | Parameter   | Test Conditions   | Min  | Тур            | Max             | Units |
|--|---|---|------|----------------|-----------------|-------|
| Off Char                               | acteristics                                       |   |      |                | 1               |       |
| BV <sub>DSS</sub>                      | Drain-Source Breakdown Voltage                    | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$  | -20  |                |                 | V     |
| ΔBV <sub>DSS</sub><br>ΔT, <sub>J</sub> | Breakdown Voltage Temperature<br>Coefficient      | $I_D = -250 \mu A$ , Referenced to 25°C   |      | -13            |                 | mV/°C |
| I <sub>DSS</sub>                       | Zero Gate Voltage Drain Current                   | $V_{DS} = -16 \text{ V},  V_{GS} = 0 \text{ V}$   |      |                | -1              | μΑ    |
| I <sub>GSSF</sub>                      | Gate-Body Leakage, Forward                        | $V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$   |      |                | 100             | nA    |
| I <sub>GSSR</sub>                      | Gate-Body Leakage, Reverse                        | $V_{GS} = -8 \text{ V}$ $V_{DS} = 0 \text{ V}$  |      |                | -100            | nA    |
| On Char                                | acteristics (Note 2)                              |   |      |                |                 |       |
| $V_{\text{GS(th)}}$                    | Gate Threshold Voltage                            | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$   | -0.4 | -0.8           | -1.5            | V     |
| $\Delta V_{GS(th)} \over \Delta T_J$   | Gate Threshold Voltage<br>Temperature Coefficient | $I_D = -250 \mu A$ , Referenced to $25^{\circ}C$  |      | 3              |                 | mV/°C |
| R <sub>DS(on)</sub>                    | Static Drain–Source<br>On–Resistance              | $\begin{array}{cccc} V_{GS} = -4.5 \ V, & I_D = -2.4 \ A \\ V_{GS} = -2.5 \ V, & I_D = -2.0 \ A \\ V_{GS} = -1.8 \ V, & I_D = -1.8 \ A \end{array}$ |      | 36<br>47<br>65 | 52<br>70<br>100 | mΩ    |
| I <sub>D(on)</sub>                     | On-State Drain Current                            | $V_{GS} = -4.5 \text{ V}, \qquad V_{DS} = -5 \text{ V}$   | -10  |                |                 | Α     |
| <b>g</b> FS                            | Forward Transconductance                          | $V_{DS} = -5 \text{ V}, \qquad I_{D} = -1.25 \text{ A}$   |      | 12             |                 | S     |
| Dynamic                                | Characteristics                                   |   |      |                |                 |       |
| C <sub>iss</sub>                       | Input Capacitance                                 | $V_{DS} = -10 \text{ V},  V_{GS} = 0 \text{ V},$  |      | 1312           |                 | pF    |
| Coss                                   | Output Capacitance                                | f = 1.0 MHz   |      | 240            |                 | pF    |
| C <sub>rss</sub>                       | Reverse Transfer Capacitance                      | 7   |      | 106            |                 | pF    |
| Switchin                               | g Characteristics (Note 2)                        |   |      | •              |                 |       |
| t <sub>d(on)</sub>                     | Turn-On Delay Time                                | $V_{DD} = -10 \text{ V}, \qquad I_D = -1 \text{ A},$  |      | 15             | 27              | ns    |
| t <sub>r</sub>                         | Turn-On Rise Time                                 | $V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$  |      | 15             | 27              | ns    |
| t <sub>d(off)</sub>                    | Turn-Off Delay Time                               |   |      | 40             | 64              | ns    |
| t <sub>f</sub>                         | Turn-Off Fall Time                                |   |      | 25             | 40              | ns    |
| Qg                                     | Total Gate Charge                                 | $V_{DS} = -10 \text{ V},  I_{D} = -2.4 \text{ A},$  |      | 12             | 20              | nC    |
| Q <sub>gs</sub>                        | Gate-Source Charge                                | $V_{GS} = -4.5 \text{ V}$   |      | 2              |                 | nC    |
| $Q_{gd}$                               | Gate-Drain Charge                                 |   |      | 2              |                 | nC    |
| Drain-S                                | ource Diode Characteristics                       | and Maximum Ratings   |      |                |                 |       |
| Is                                     | Maximum Continuous Drain-Source                   |   |      |                | -0.42           | Α     |
| V <sub>SD</sub>                        | Drain-Source Diode Forward<br>Voltage             | $V_{GS} = 0 \text{ V},  I_{S} = -0.42  \text{(Note 2)}$   |      | -0.6           | -1.2            | V     |

#### Notes:

<sup>1.</sup>  $R_{\theta,JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta,JC}$  is guaranteed by design while  $R_{\theta,CA}$  is determined by the user's board design.



a) 250°C/W when mounted on a 0.02 in² pad of 2 oz. copper.



b) 270 ℃/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%

# **Typical Characteristics**

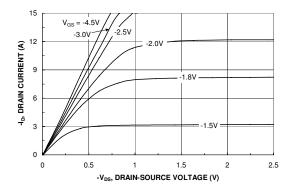
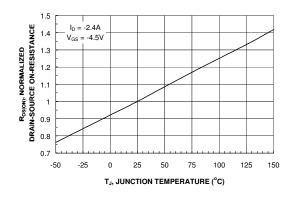


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



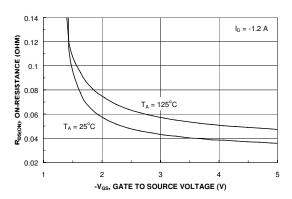
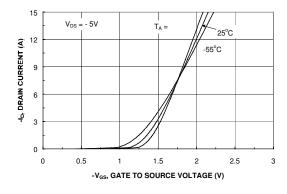


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



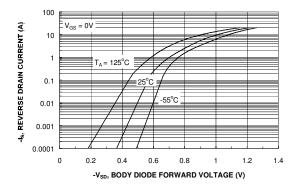
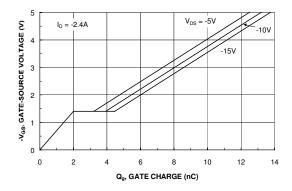


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**



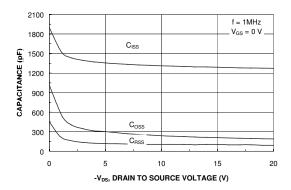
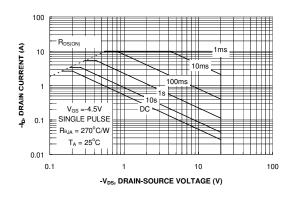


Figure 7. Gate Charge Characteristics.





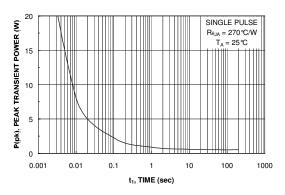


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

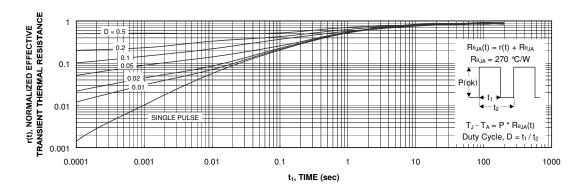


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

### **TRADEMARKS**

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

FASTr™ ACEx™ SMART START™ **VCX**<sup>TM</sup> OPTOLOGIC® FRFET™ **SPM<sup>TM</sup>** Bottomless™ OPTOPLANAR™ CoolFETTM GlobalOptoisolator™ PACMAN™ Stealth™ РОРТМ SuperSOT™-3 CROSSVOLT™ GTO™ Power247™ **DOMETM** HiSeC™ SuperSOT™-6 I<sup>2</sup>CTM SuperSOT™-8 EcoSPARK™ PowerTrench ® E<sup>2</sup>CMOS<sup>TM</sup> SyncFET™ ISOPLANAR™ QFET™  $OS^{TM}$ EnSigna™ LittleFET™ TinyLogic™ FACT™ MicroFET™ TruTranslation™ QT Optoelectronics™ UHC™ FACT Quiet Series™ MicroPak™ Quiet Series™

FACT Quiet Series MicroPak Quiet Series UHC UHC FAST MICROWIRE SILENT SWITCHER UltraFET SILENT SWITCHER UltraFET

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS. NOR THE RIGHTS OF OTHERS.

### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

### PRODUCT STATUS DEFINITIONS

### **Definition of Terms**

| Datasheet Identification | Product Status            | Definition  |
|--------------------------|---------------------------|---|
| Advance Information      | Formative or<br>In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.  |
| Preliminary              | First Production          | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| No Identification Needed | Full Production           | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.   |
| Obsolete                 | Not In Production         | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.   |